

<b>Notice of References Cited</b>	Application/Control No. 09/935,344	Applicant(s)/Patent Under Reexamination JIRA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0001595	01-2002	Sonntag et al.	424/208.1
*	B	US-2003/0143221	07-2003	Loibner et al.	424/130.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 00/24420	05-2000	EP	Sonntag et al.	-----
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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